## Application/Control No. Applicant(s)/Patent Under Reexamination 10/044,008 JAIN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Shin-Hon Chen 2131

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0037453	11-2001	Mitty et al.	713/168
*	В	US-6,904,521	06-2005	Jivsov, Andrey	713/155
*	С	US-6,963,971	11-2005	Bush et al.	713/153
*	۵	US-2003/0046533	03-2003	Olkin et al.	713/152
	Ε	US-			
	F	US-			
ĺ	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.